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(12) **United States Design Patent**
Biselx et al.

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(54) **MICROMETER**

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(73) Assignee: **TESA SA**, Renens (CH)

(**) Term: **14 Years**

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(30) **Foreign Application Priority Data**

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(52) **U.S. Cl.**
USPC **D10/73**

(58) **Field of Classification Search**
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G01B 3/18; G01B 3/008; G01J 3/02; G01J
3/0208; G01J 3/0291; G01J 3/50; G01J 3/501;
G01J 3/0289; G01J 3/0243
See application file for complete search history.

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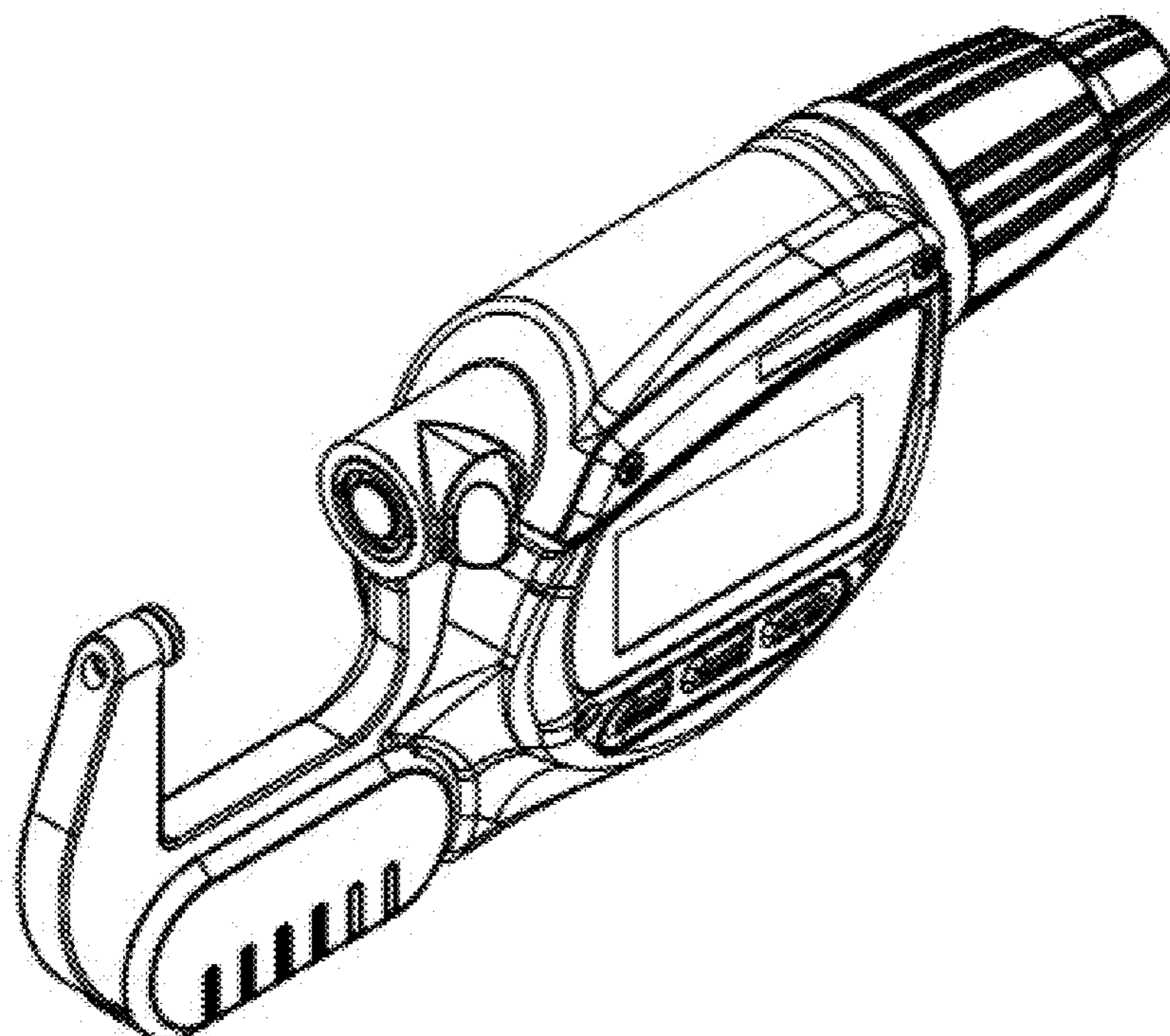
(57) **CLAIM**

The ornamental design for a micrometer, as shown and described.

DESCRIPTION

FIG. 1 is an upper perspective view of an exemplary micrometer;
FIG. 2 is a front view of the micrometer;
FIG. 3 is a rear view of the micrometer;
FIG. 4 is a bottom view of the micrometer;
FIG. 5 is a top view of the micrometer;
FIG. 6 is a left side view of the micrometer;
FIG. 7 is a front view of another exemplary micrometer, with the other views the same as shown above in connection with FIG. 1; and,
FIG. 8 is a front view of still another exemplary micrometer, with the other view the same as shown above in connection with FIG. 1.

1 Claim, 8 Drawing Sheets



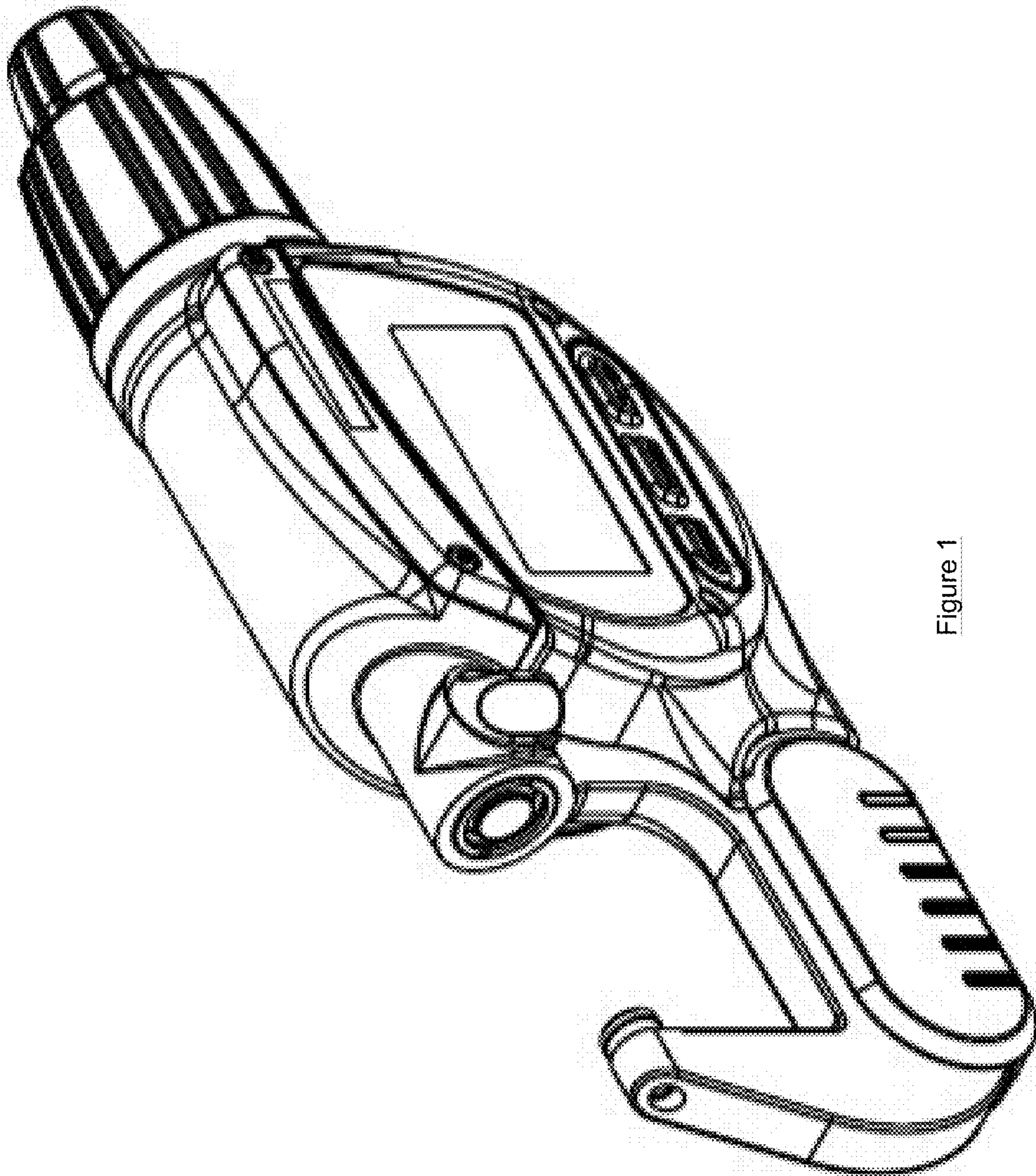


Figure 1

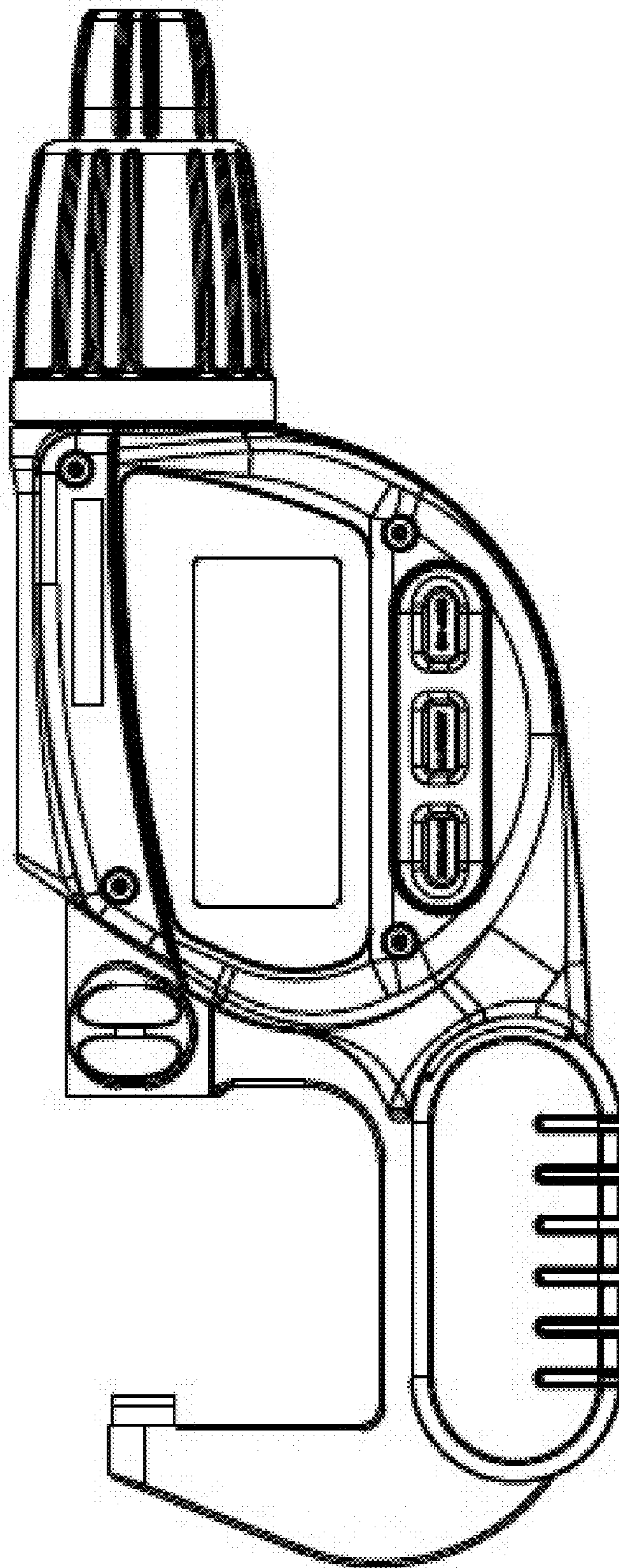


Figure 2

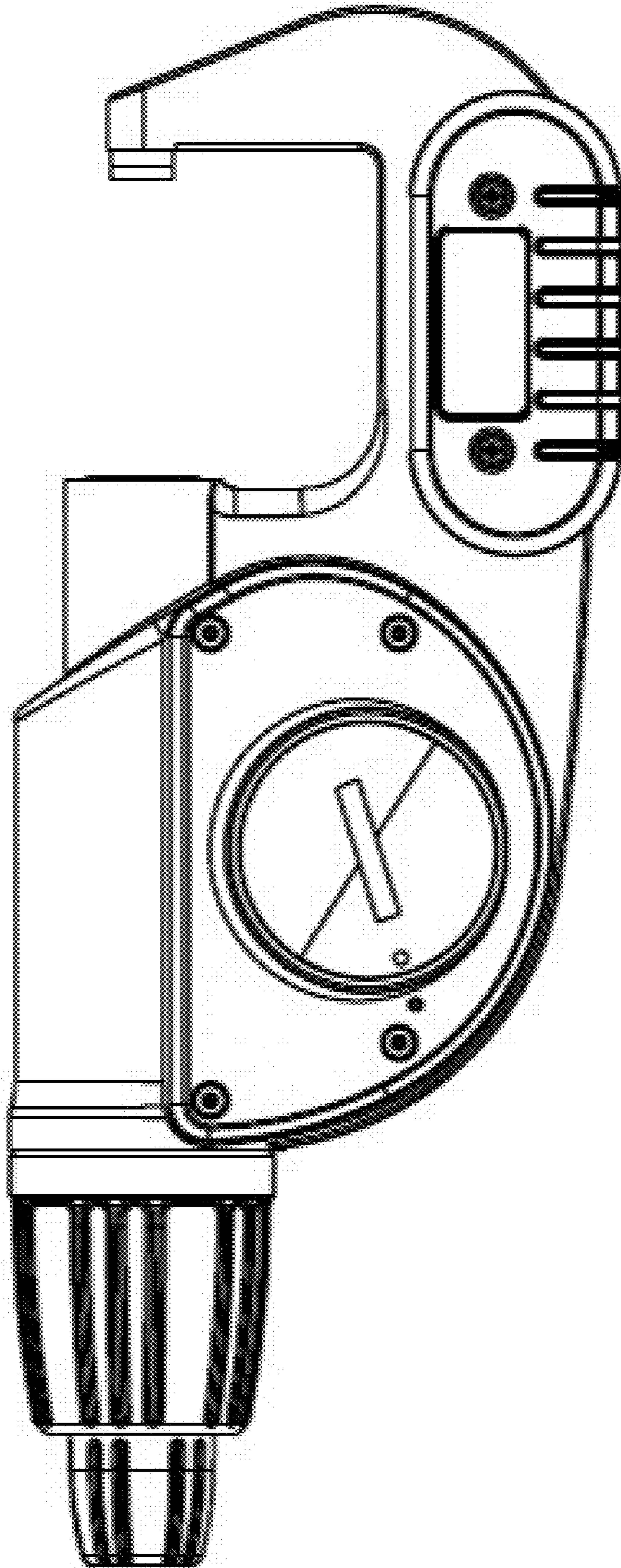


Figure 3

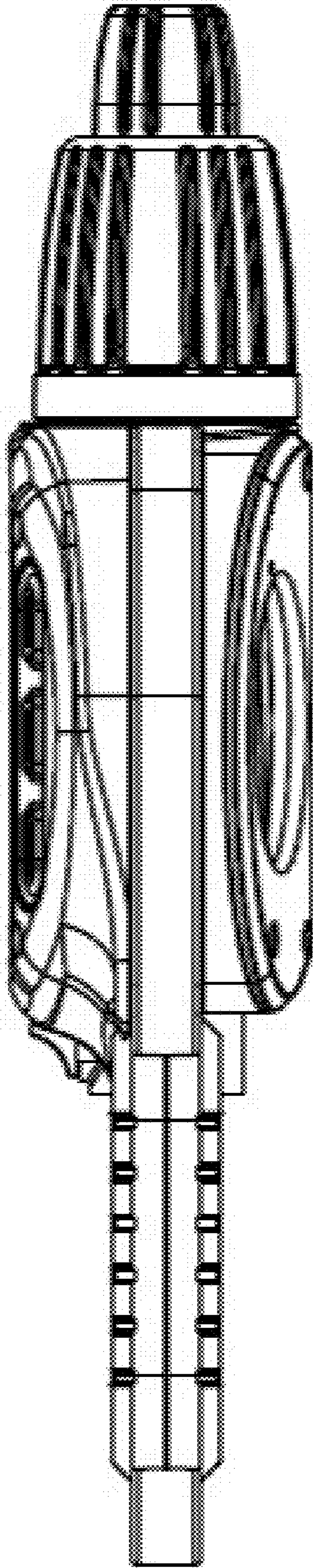


Figure 4

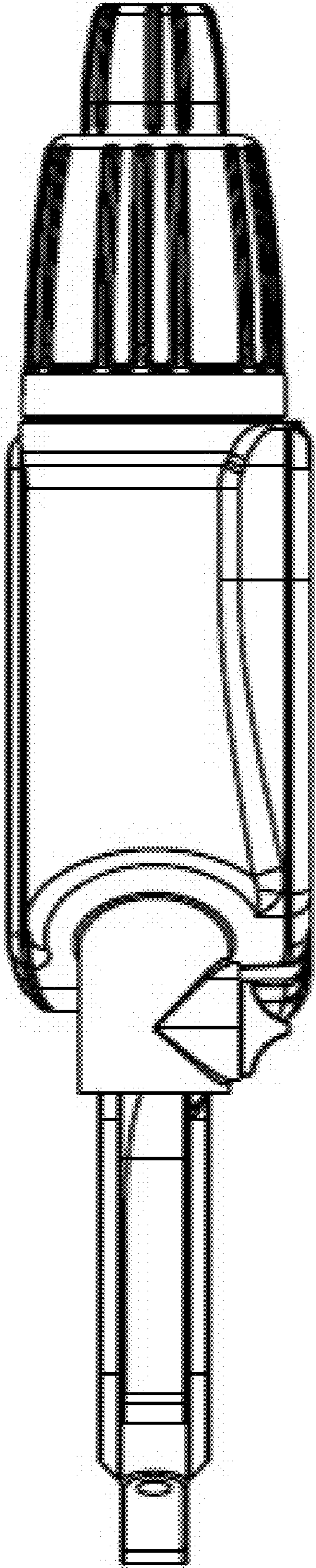


Figure 5

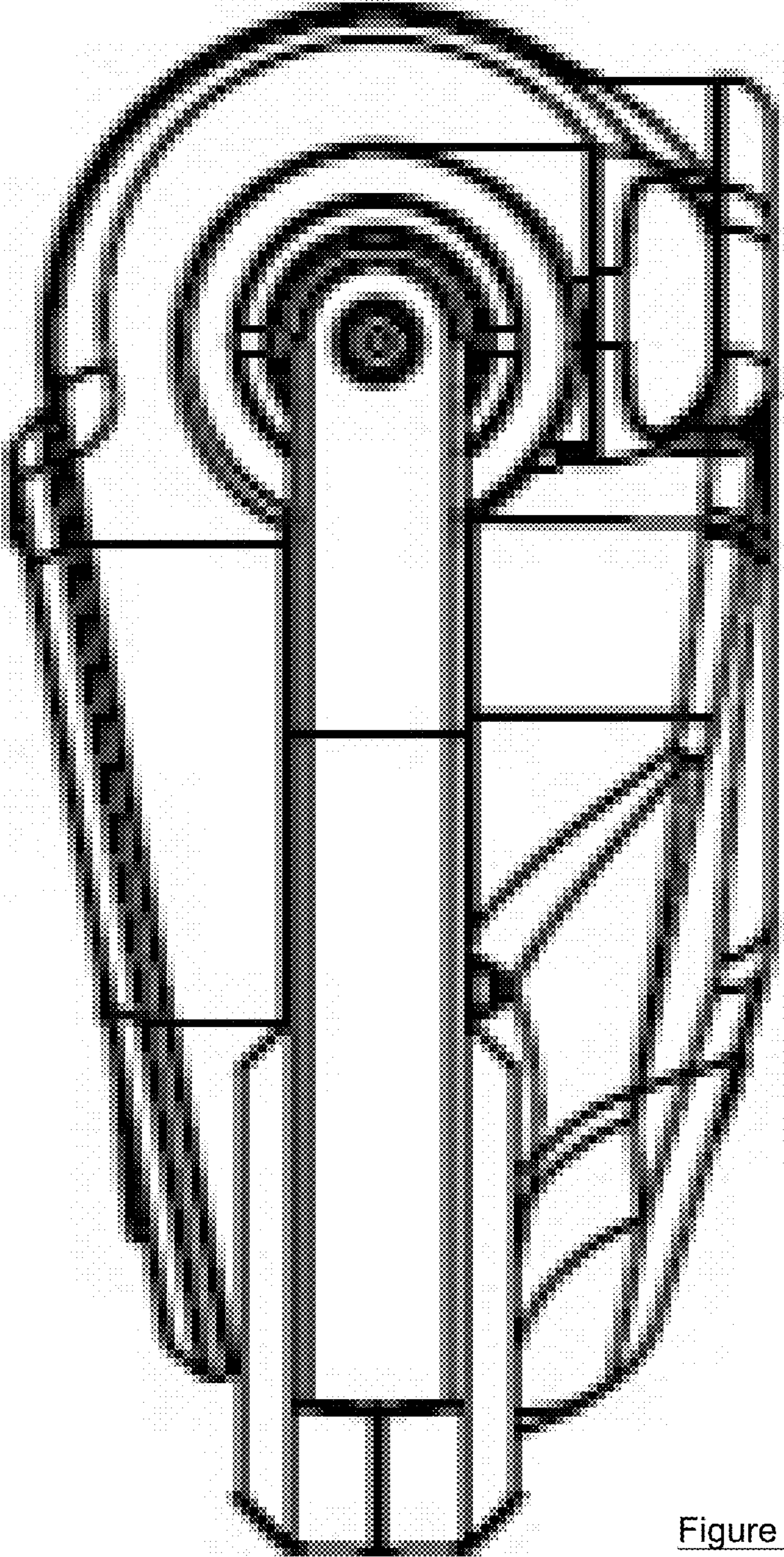


Figure 6



Figure 7



Figure 8